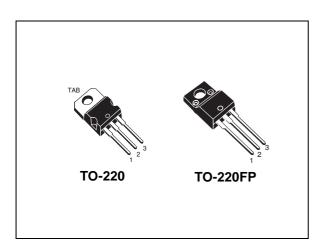


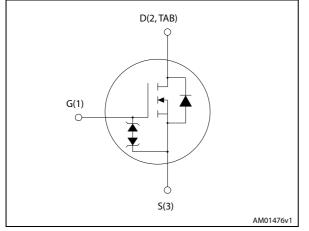
# STP4NK60Z, STP4NK60ZFP

Datasheet - production data

# N-channel 600 V, 1.7 Ω typ., 4 A Zener-protected SuperMESH<sup>™</sup> Power MOSFETs in TO-220 and TO-220FP packages



## Figure 1. Internal schematic diagram



## Features

Order codes	$v_{\text{DS}}$	R <sub>DS(on) max.</sub>	P <sub>TOT</sub>	Ι <sub>D</sub>
STP4NK60Z	600 V	20	70 W	4 A
STP4NK60ZFP		2 12	70 VV	4 A

- 100% avalanche tested
- Very low intrinsic capacitances
- Zener-protected

# Applications

Switching applications

# Description

These devices are N-channel Zener-protected Power MOSFETs developed using STMicroelectronics' SuperMESH<sup>™</sup> technology, achieved through optimization of ST's well established strip-based PowerMESH<sup>™</sup> layout. In addition to a significant reduction in onresistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

## Table 1. Device summary

Order codes	Marking	Packages	Packaging
STP4NK60Z	P4NK60Z	TO-220	Tube
STP4NK60ZFP	P4NK60ZFP	TO-220FP	Tube

DocID025020 Rev 2

www.st.com

This is information on a product in full production.

# Contents

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuits
4	Package mechanical data 10
5	Revision history15



# 1 Electrical ratings

Symbol	Parameter	Value		Unit
Symbol	Falameter	TO-220	TO-220FP	Onit
V <sub>DS</sub>	Drain-source voltage	6	00	V
V <sub>GS</sub>	Gate- source voltage	±	± 30	
I <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	4 4 <sup>(1)</sup>		А
Ι <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	2.5 2.5 <sup>(1)</sup>		А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	16 16 <sup>(1)</sup>		А
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	70 25		W
	Derating factor	0.56 0.2		W/°C
ESD	Gate-source human body model (C=100 pF, R=1.5 $k\Omega)$	3		kV
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	4.5		V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; $T_C$ =25 °C)	2500		V
T <sub>stg</sub>	Storage temperature	-55 t	o 150	°C
Т <sub>ј</sub>	Max operating junction temperature	1	50	°C

### Table 2. Absolute maximum ratings

1. Limited by maximum junction temperature.

2. Pulse width limited by safe operating area

3.  $I_{SD} \leq$  4 A, di/dt  $\leq$  200 A/µs,  $V_{DD} \leq$   $V_{(BR)DSS}$ ,  $T_J \leq$   $T_{JMAX}$ .

### Table 3. Thermal data

Symbol	Parameter	Parameter		Unit
Symbol	Farameter	TO-220	TO-220FP	Onit
R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max	62.5		°C/W

### Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{j max}$ )	4	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}, I_D = I_{AR}, V_{DD} = 50 \text{ V}$ )	120	mJ



#### **Electrical characteristics** 2

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> =1 mA	600			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 600 V V <sub>DS</sub> = 600 V, T <sub>C</sub> = 125 °C			1 50	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 50 \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A		1.7	2	Ω

#### Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 2 \text{ A}$	-	3		S	
C <sub>iss</sub>	Input capacitance		-	510		pF	
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> = 0	-	67		pF	
C <sub>rss</sub>	Reverse transfer capacitance	VGS - V	-	13		pF	
C <sub>oss eq.</sub> <sup>(2)</sup>	Equivalent output capacitance	$V_{DS} = 0, V_{DS} = 0 \text{ to } 480 \text{ V}$	-	38.5		pF	
t <sub>d(on)</sub>	Turn-on delay time		-	12		ns	
t <sub>r</sub>	Rise time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 2 \text{ A},$	-	9.5		ns	
t <sub>d(off)</sub>	Turn-off delay time	R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see <i>Figure 17</i> )	-	29		ns	
t <sub>f</sub>	Fall time		-	16.5		ns	
t <sub>r(Voff)</sub>	Off-voltage rise time	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4 A,	-	12		ns	
t <sub>r</sub>	Fall time	R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V	-	12		ns	
t <sub>c</sub>	Cross-over time	(see <i>Figure 19</i> )	-	19.5		ns	
Qg	Total gate charge	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 4 A,	-	18.8	26	nC	
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	3.8		nC	
Q <sub>gd</sub>	Gate-drain charge	(see <i>Figure 18</i> )	-	9.8		nC	

1. Pulsed: pulse duration= $300\mu$ s, duty cycle 1.5%

2.  $C_{oss eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ .



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		4	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		16	Α
$V_{SD}^{(2)}$	Forward on voltage	I <sub>SD</sub> = 4 A, V <sub>GS</sub> = 0	-		1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4 A, di/dt = 100 A/µs	-	400		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 24 V, Tj = 150 °C	-	1700		nC
I <sub>RRM</sub>	Reverse recovery current	(see <i>Figure 19</i> )	-	8.5		А

Table 7. Source drain diode

1. Pulsed: pulse duration =  $300 \,\mu$ s, duty cycle 1.5%

2. Pulse width limited by safe operating area

Table 8. Gate-source Zener diode	Table 8	. Gate-source	Zener	diode
----------------------------------	---------	---------------	-------	-------

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 1$ mA, $I_{D}=0$	30	-	-	V

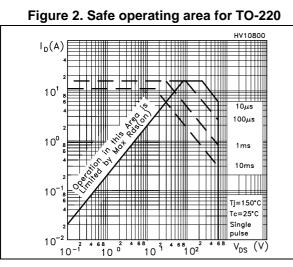
The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.



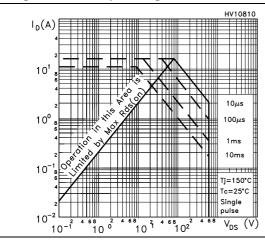
 $Z_{th} = k R_{thJ-c}$ 

 $\delta = t_p / \tau$ 

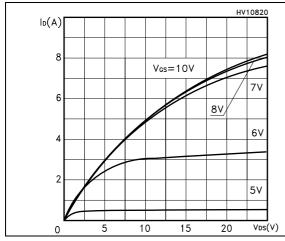
## 2.1 Electrical characteristics (curves)

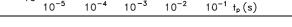






## Figure 6. Output characteristics





0.01

SINGLE PULSE

Figure 3. Thermal impedance for TO-220

Κ

 $10^{-1}$ 

-2

10

 $\delta = 0.5$ 

0.2

0.1

0.0

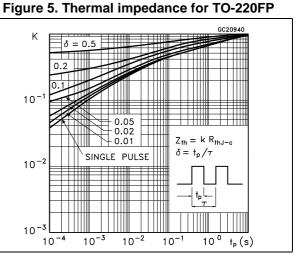
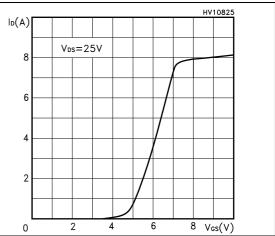


Figure 7. Transfer characteristics





HV10860

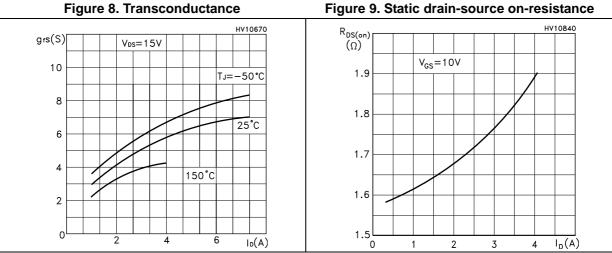
Ciss

Coss

 $V_{DS}(V)$ 

40

### Figure 8. Transconductance



C(pF)

800

600

0

### Figure 10. Gate charge vs gate-source voltage

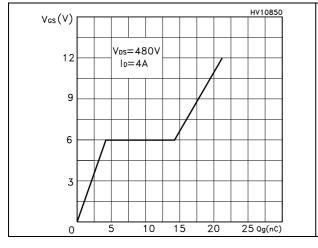
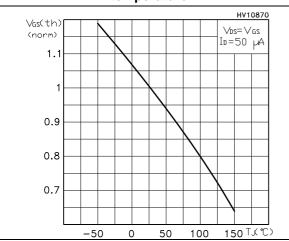


Figure 12. Normalized gate threshold voltage vs temperature





10

Figure 11. Capacitance variations

f=1MHz V<sub>GS</sub>=0V

Figure 13. Normalized R<sub>DS(on)</sub> vs temperature

30

20

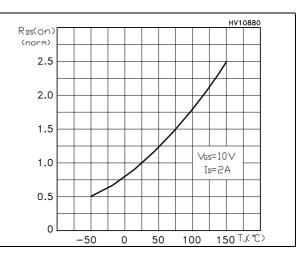




Figure 14. Source-drain diode forward characteristic

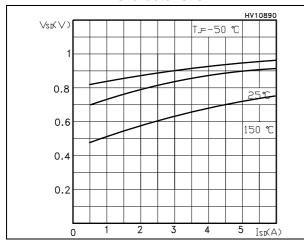
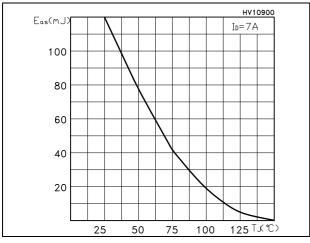
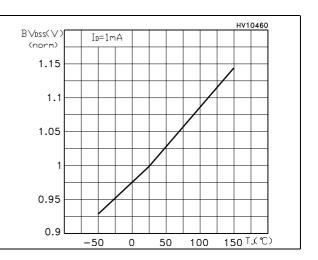


Figure 16. Avalanche energy vs temperature



# Figure 15. Normalized $V_{\text{DS}}$ vs temperature





# 3 Test circuits

Figure 17. Switching times test circuit for resistive load

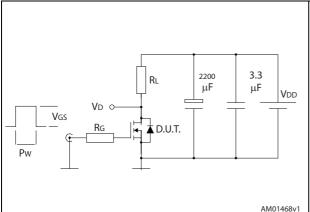


Figure 19. Test circuit for inductive load switching and diode recovery times

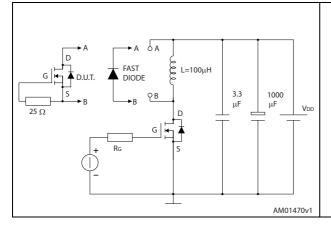


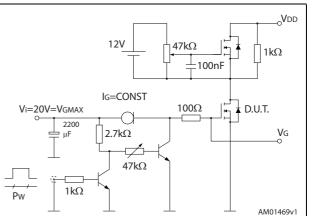
Figure 21. Unclamped inductive waveform

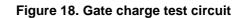
VD

ldм

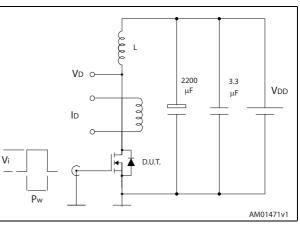
lр

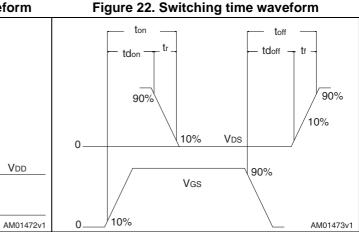
V(BR)DSS













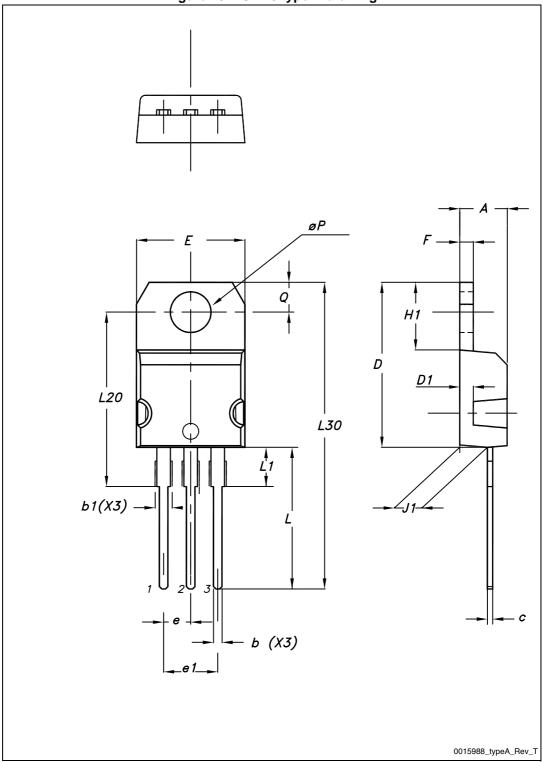
Vdd

# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.



Figure 23. TO-220 type A drawing





Dim. —	mm			
	Min.	Тур.	Max.	
А	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
Øр	3.75		3.85	
Q	2.65		2.95	

Table 9. TO-220 type A mechanical data



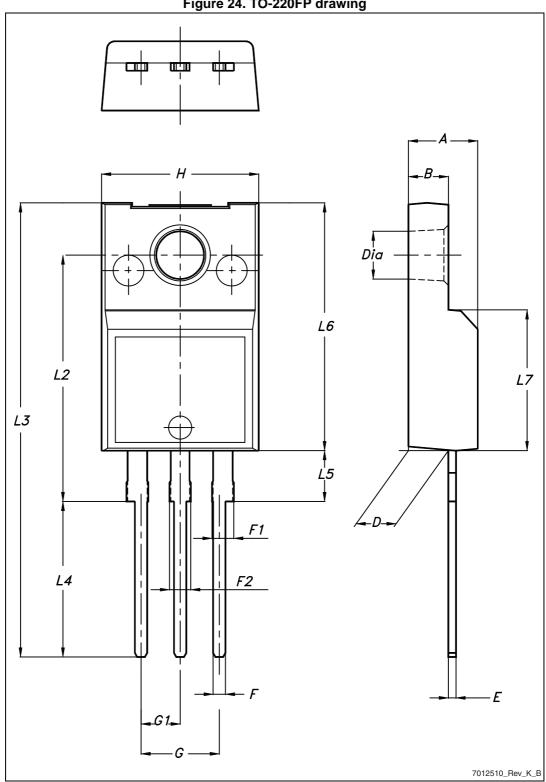


Figure 24. TO-220FP drawing



	Table 10. TO-220FP mechanical data				
Dim.	mm				
	Min.	Тур.	Max.		
А	4.4		4.6		
В	2.5		2.7		
D	2.5		2.75		
E	0.45		0.7		
F	0.75		1		
F1	1.15		1.70		
F2	1.15		1.70		
G	4.95		5.2		
G1	2.4		2.7		
н	10		10.4		
L2		16			
L3	28.6		30.6		
L4	9.8		10.6		
L5	2.9		3.6		
L6	15.9		16.4		
L7	9		9.3		
Dia	3		3.2		

Table '	10.	TO-220FP	mechanical	data
abic	10.		meenamear	uata



# 5 Revision history

Date	Revision	Changes
19-Jul-2013	1	First release. Part numbers previously included in datasheet DocID8882
22-Jan-2014	2	<ul> <li>Modified: figure in cover page</li> <li>Minor text changes</li> </ul>

### Table 11. Document revision history



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